Webinar powered by

First Solar

25 May 2020

4 PM - 5 PM CEST, Berlin

10 AM - 11 AM EDT, New York

7.30 PM - 8.30 PM | IST, India



Mark Hutchins Editor | pv magazine



Quantify the impacts of cell cracking in the field



Lou Trippel First Solar



Tristan Erion-Lorico PVEL



IIT Bombay



Anil Kottantharayil Prakash Suratkar **PV Diagnostics**

Si PV Modules – Microcracks and Power Loss

Anil Kottantharayil, Ph. D.

National Centre for Photovoltaic Research and Education (NCPRE)

Professor of Electrical Engineering

Indian Institute of Technology Bombay

anilkg@ee.iitb.ac.in

PV Magazine Cell Cracking Webinar – 25 May 2020





National Centre for Photovoltaic Research and Education

NCPRE

funded by the

Ministry of New and Renewable Energy (MNRE)

Government of India

at

IIT Bombay

In existence since 2010

29 Faculty members 91 Students and Staff Supported,

About 156 students working on Solar PV

Education & Training

Advanced Si-Solar cell

Thin Film Devices

Energy Storage

Power Electronics

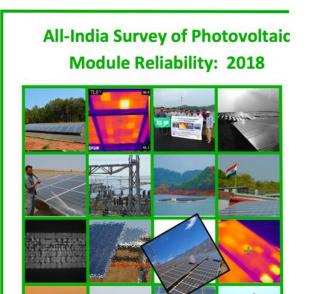
PV Module Reliability

Industry Affiliate Program & Industry Interaction





PV Module Reliability @ NCPRE



National Centre for Photovoltaic Research and Education (NCPRE), IIT Bombay

National Institute of Solar Energy (NISE), Gurugram







All India Surveys of PV Module Reliability – 2013, 2014, 2016, 2018



Laboratory and outdoor test facilities for modules











Field test services for industry

Impact of Transportation on Indian Roads, on PV Modules

¹Devan P. Vasudevan, ²Parth Bhatt, ¹Anii Kottantharayil
iational Centre for Photovoltaic Research and Education, and Department of Electrical Engineering,
Indian Institute of Technology Bombay, Mumbai, Maharashtra, 400076, India.

²Waarce Energies Ltd, Surat, Gujarat, 394230, India.

of vibrations experienced by PV modules during transportation, prescribed in ECC2579-12:2015, competent of the prescription of the pre

20 PV modules were placed vertically on top of the cardboxer. The sides aligned to the plane of the modules are secured wit cardboard sheets at the ends of the package. Subsequently package is wrapped in platics thesets. All four corners of the package are secured by thick cardboard sheets. The packet then secured by platics traps. This packaging method, show in Fig. 1, is wisely used for transporting PV modules to larg power plants.



Identification of Stressors Leading to Degradation of Antisoiling Coating in Warm and Humid Climate Zones

Sonali Bhaduri [©], Ajeesh Alath, Sudhanshu Mallick, Narendra S. Shiradkar, and

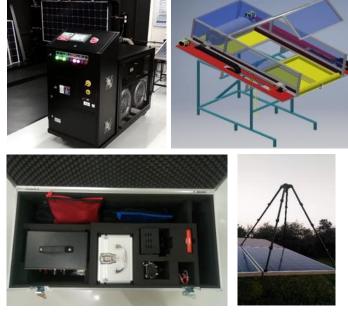
on exposure in Mumbal weather conditions, where losses due doubt deposition go up to 50% in the months. The context angle the antisolling coatings changed from hydropholic to hydrophilo context angle < 50% in 12 weeks of field exposure. By testing the context of the coating changed from hydropholic to hydrophilo context angle < 50% in 12 weeks of field exposure. By testing significant reduction of rais of dust deposition was observed on the coater flow module throughout the year. Soiling less of the coate module went back to zero after every cleaning run tout seen in the unceated module, by allowing the same of certaing in the coater module went back to zero after every cleaning run tout seen in the unceated module, by allowing the coater module for his properties of module above lower soil ingloss them the coated module. Signatures of stresses identified to their print in all after which the unceated module shows lower soil ingloss them the coated module. Signatures of stresses identified to during rain caused significant particular free testing the coater of the coater of the was verified by the indoor individual stress testi, and 2) frequer manual cleaning runs, which lead to alteration by dust and was cleaning on the field was more every as, in real field conditions.

22 MYMon* of IV does and 441 h of condensation. However, in lathor torons texts with helf-third divestory CV engagement of the immersions, very high stress levels are required for princings a similar extent of degradation.

Index Terms—Act of rais, matesialing (AS) coating, contact angle, dost, mitigation, photovoltaic (IV) medules, soiling loss, Wilcoxon signed-rank ktr.

B HAD reported an series question rate in excess of the control of

Development of new standards for Indian conditions



Development of tools for testing



PVDiagnostics



Sun Connect India

Mentoring of startups



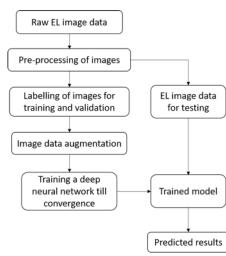


Activities Specific to Microcracks

- On-site in-plant EL measurements
- Developed low cost EL camera and kit
- Developed Dynamic Mechanical Loading test equipment
- Environmental stress after mechanical stress
- Transportation studies
- Machine Learning for crack detection from EL images











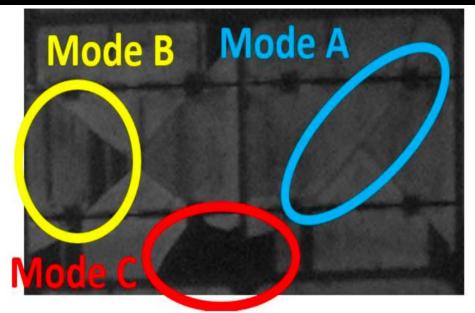
Micro-Cracks in Si PV – How Does It Happen?

- Cell manufacturing processes e.g. texturization
- Module manufacturing processes e.g. soldering
- Module handling for test & packaging
- Module transportation
- Installation
- Maintenance e.g. cleaning of panels
- Hail, wind, snow & sand loading
- Thermal cycling during operation

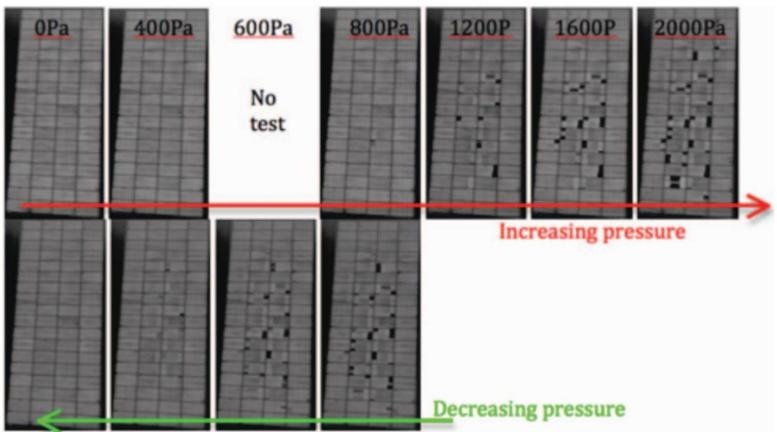




Micro-Cracks in Si PV – Electroluminescence Images



All India Survey of Photovoltaic Module Reliability 2018, NCPRE, IIT Bombay



A. M. Gabor, et al., IEEE 43rd PVSC, 2016.

Interesting video from NREL: https://www.youtube.com/watch?v=-qdyxlybmoc

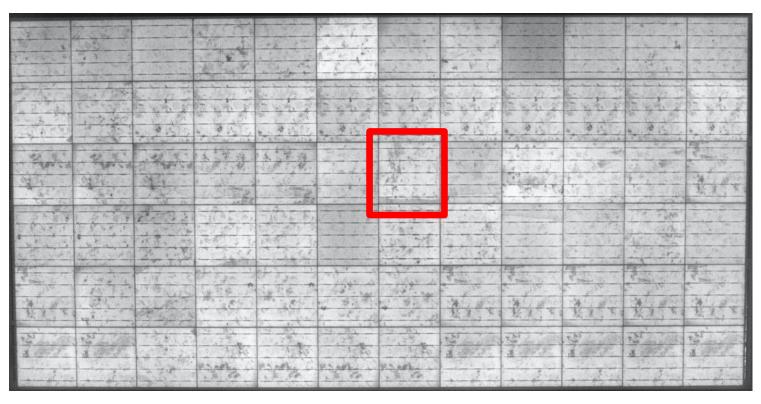
- Appearance of cracks in EL images decided by the pressure on the panel at the time of imaging
- The same applies to impact of cracks on performance





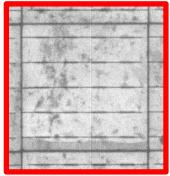
Micro-Cracks in Si PV – Electroluminescence Images

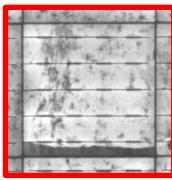
EL at 30% of Isc



EL at Isc: Cracks and other defects are more visible







- Appearance of cracks in EL image is decided by the current at which EL image is taken
- The same applies to impact of cracks on performance

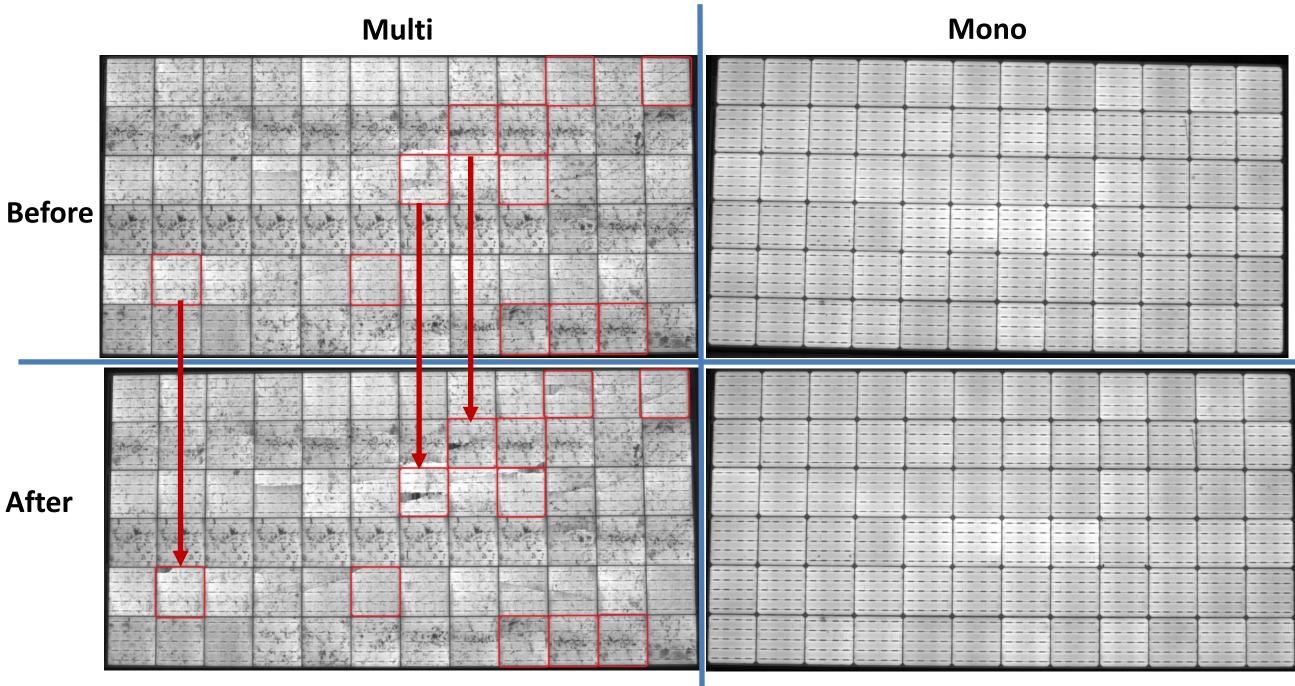
Devan Vasudevan, NCPRE, IIT Bombay





Mono versus Multi Crystalline Silicon

Modules subjected to identical transportation stress.

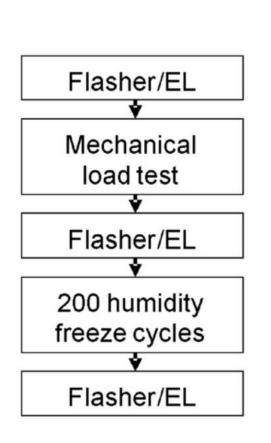


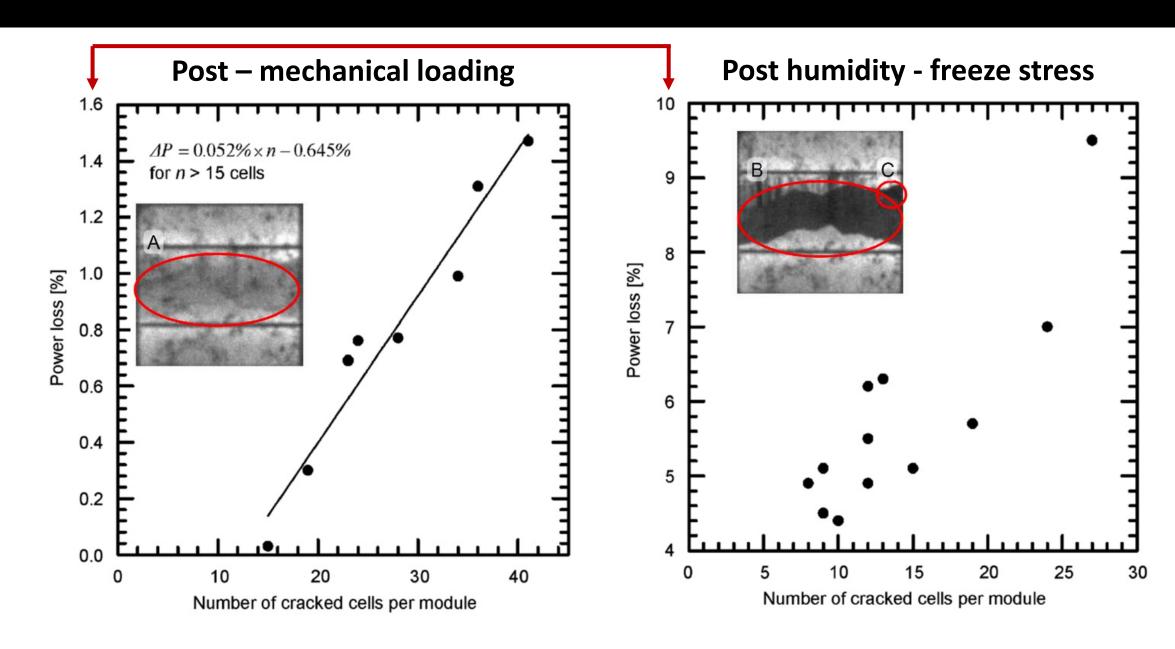
- Devan Vasudevan, NCPRE, IIT Bombay
- Mono is more robust to mechanical stress
- Indian market share of mono in 2017 was 5% (www.pv-tech.org, Sep. 2019.)





Post Crack Generation Stress Enhance the Cracks and Their Impact on Performance





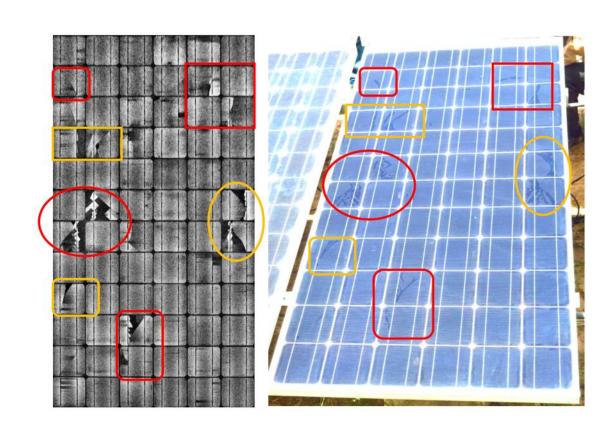
M. Köntges, Solar Energy Materials and Solar Cells, 2011.

- A-type cracks converted to B- and C-type with larger area after HF stress
- Leading to significant powerloss enhancement after HF stress

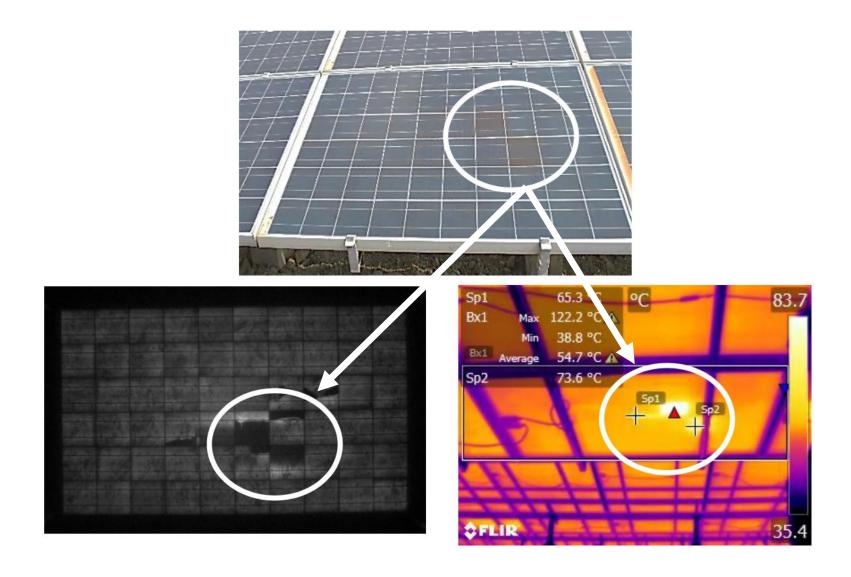




Cracks and "Other" Defects



Cracks in cells can lead to snail trails, indicating moisture ingress through the crack.



Severe cracking of cells in a module can lead to hot-spots and related problems.

All India Survey of Photovoltaic Module Reliability 2018, NCPRE, IIT Bombay

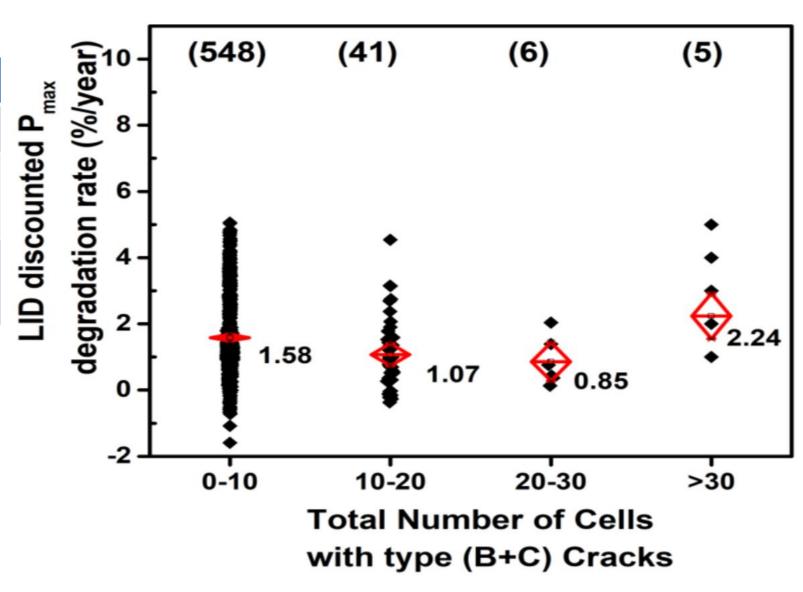




2018 All India Survey Results – Micro Cracks

Multi: Mono ~ 9:2

Percentage of cells with different types of cracks									
	Mode A	Mode B	Mode C	No. cells checked					
Ground Mounted	8.90%	4.81%	1.12%	31368					
Roof Mounted	5.13%	2.01%	0.82%	5712					



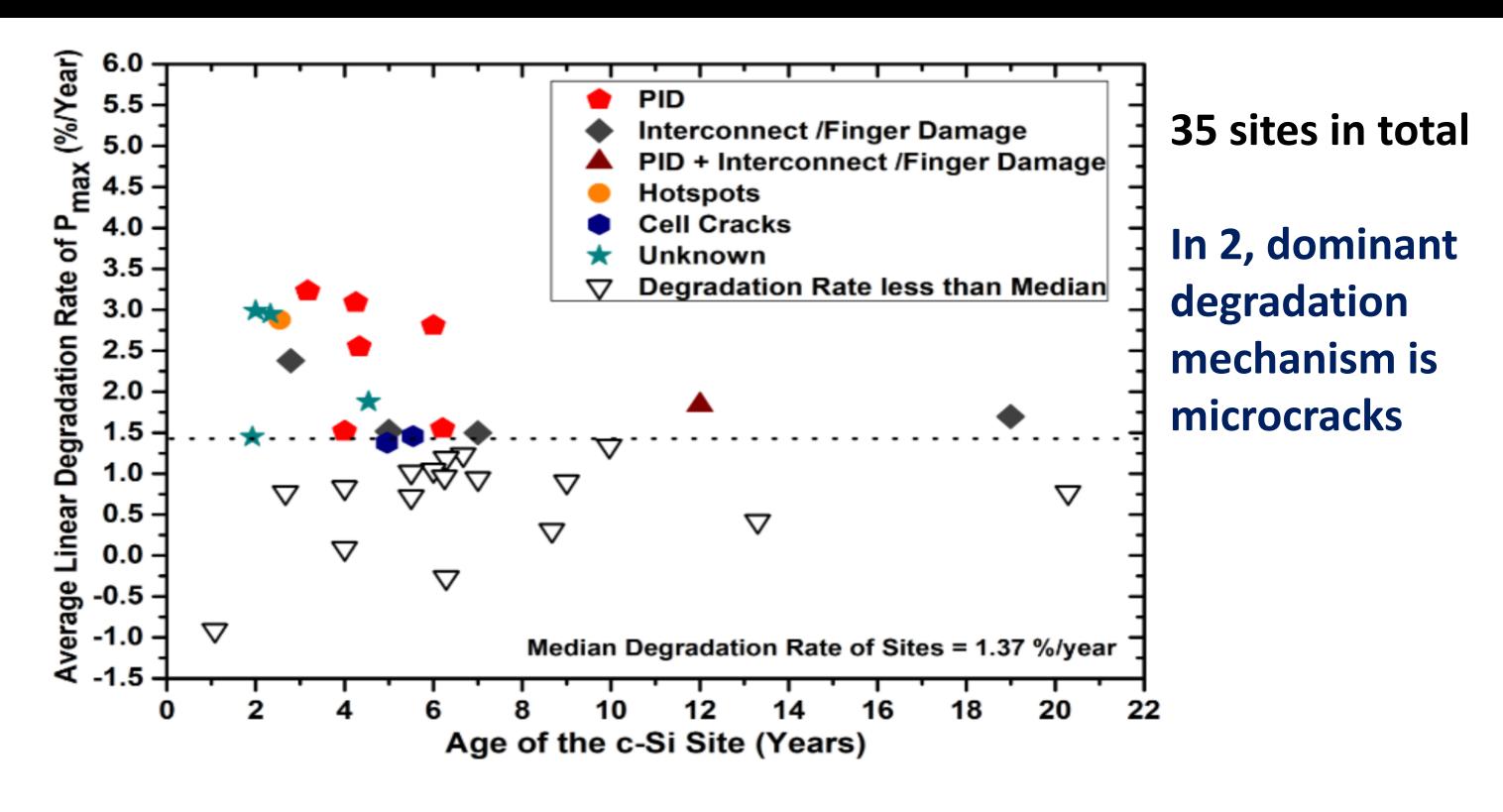
No clear correlation was observed between number of cells with cracks and STC power degradation in field survey.

All India Survey of Photovoltaic Module Reliability 2018, NCPRE, IIT Bombay





2018 All India Survey Results - Micro Cracks (2)



Survey sites where microcracks were the dominant degradation mode had degradation rates similar as the median of all modules surveyed.

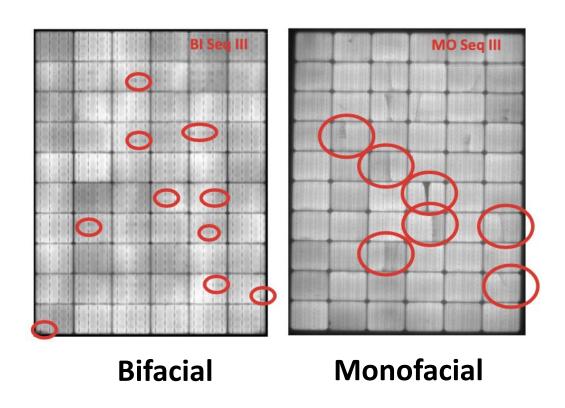


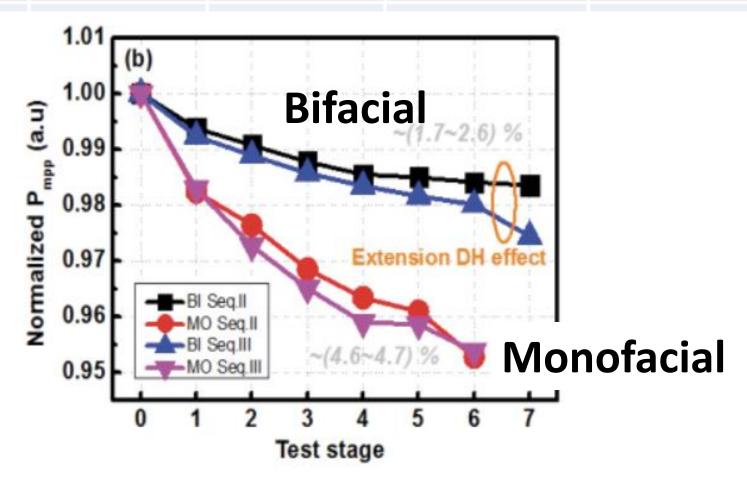
Looking Ahead: Bifacial Modules

Glass – glass modules are expected to be more robust to mechanical stress, and moisture/ O_2 ingress.

C. Lien et al., IEEE 7th World Conference on Photovoltaic Energy Conversion (WCPEC), 2018.

Seq. II	Precon. 15kWh/m ²	UV 80℃ 15kWh/m²	DML acc. to IEC TS 62782	TC 50	HF 10	DH 85/85 (1000 h)	DH 85/85 (1000 h)
Seq. III	Precon. 15kWh/m ²	UV 100°C 15kWh/m ²	DML acc. to IEC TS 62782	TC 50	HF 10	DH 85/85 (1000 h)	DH 85/85 (1000 h)





Glass – Glass bifacial modules are more robust to cracking.





Key Takeaways

- Severity of cracks in EL images and impact on performance depends on
 - Current through the module
 - Mechanical stress at the time of measurement
- Mono crystalline cells are more robust to cracking than multi
- Cracks transform to higher severity during long term operation/environmental stress
- Cracks are sometimes the underlying cause of hot-spots and snail trails
- In NCPRE NISE 2018 All India Survey:
 - 8.3% of cells were found to have cracks
 - No clear correlation was observed between number of cracks and power degradation
 - In 2 out of 35 sites, micro cracks were found to be the dominant module degradation mechanism
- Glass to glass bifacial modules are more robust to cell cracking





Thank you for your attention!





Backup Slides





Cracks robustness of Mono and Multi Silicon Modules

